# Analytical Reference Materials International

## Certificate of Analysis Certified Reference Material



### Grade: Alloy G-30 / UNS N06030

Part Number (Q.A. NO.): IARM 67C

Certificate No.: 67C-12272010-IARM-F

Revision Date: 05/08/2013

#### **Interpretation of Data**

Certificate Date: 12/27/2010

- 1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community and are reported as % wt. unless otherwise noted.
- Any data reported and enclosed by a parentheses () is a "best estimate" and is NOT CERTIFIED. This data could not be quantified sufficiently for 2. certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 3. The "Inter-Laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in brackets [] indicates further testing is in process.
- The "±Estimated Uncertainty" is enclosed by a parentheses () below the individual element's concentration and is based on a Confidence Interval at 4. 95%. Included in this estimated uncertainty, are the combined effects of method imprecision, material inhomogeneity, and any bias between methods.

Important: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

<u>Aluminum</u> 0.14 (0.01)	Antimony (0.0003)	<u>Arsenic</u>	<u>Boron</u> 0.001 (0.0004)	<u>Calcium</u>	<u>Carbon</u> 0.0058 (0.0001)	Chromium 28.9 (0.04)	<u>Cobalt</u> 1.75 (0.02)	<u>Copper</u> 1.24 (0.02)
<u>lron</u> 13.48 (0.03)	<u>Lead</u>	<u>Magnesium</u> 0.0068 (0.0002)	<u>Manganese</u> 1.01 (0.01)	<u>Molybdenum</u> 4.93 (0.01)	<u>Nitrogen</u> 0.035 (0.0005)	<u>Niobium</u> 0.36 (0.01)	<u>Nickel</u> 45.8 (0.1)	<u>Oxygen</u> 0.0016 (0.0002)
<u>Phosphorus</u> 0.011 (0.001)	<u>Silicon</u> 0.14 (0.01)	<u>Sulfur</u> 0.0006 (0.0001)	<u>Tantalum</u> (0.006)	<u>Tin</u> 0.0014 (0.0002)	<u>Titanium</u> 0.005 (0.001)	<u>Tungsten</u> 1.97 (0.02)	<u>Vanadium</u> 0.031 (0.001)	<u>Zirconium</u> 0.002 (0.001)

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

Alcoa Howmet, Dover Alloy - Dover, NJ	Anderson Laboratories, Inc Greendale, WI
ATI Allvac, Lockport - Lockport, NY	ATI Allvac, Monroe - Monroe, NC
Haynes International, Inc Kokomo, IN	Huntington Alloys Corporation - Huntington, WV
Kalco Metals, Inc - Wheatland, PA	Laboratory Testing, Inc Hatfield, PA
Latrobe Specialty Metals - Latrobe, PA	Leco Corporation - St. Joseph, MI
Special Metals IncoTest - Hereford, UK	ThyssenKrupp VDM USA - Florham Park, NJ

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are: NIST 1763, 1765, BS H3B, 197A, 925, ALPHA AR872, LECO 501-503, 502-257, BS H-8, ALPHA AR654, AR881, NIST 867, 3102A, 3106, 3107, 3109A, 3128, 3131A, 3151, 3161A, LECO 501-643, NIST 868, 3102A, 3103A, 3106, 3109A, 3114, 3128, 3131A, 3151, 3155, 3161A, 3162A, 3169, IARM 69B, BS 750A, MBH 215XHC5S, ALPHA AR669, AR881, LECO 501-643, 501-644, BCS 351, 454/1, 462/1, HAS G3A, IHR5657, LECO 501-551, 502-102, NIST 72G, 131G, BCS 346A, LECO 501-644, HAS 600T, 925A, IARM 67A, 67B, SYN 630A, QANA, Q6FB, LECO 501-991, 502-102, NIST 349A, IH T31659, 151, ALPHA AR654, AR892, NIST 864, 867, IARM 56D, 65B, 67B, 68B, 100B, LECO 601-644, 501-674, 501-929, 502-195, IARM 67A, 67B, 69B, 69C, 69D, BS H4A, H4B, H8, CSN-4, LECO 502-257, IARM 59A, 60A, 67A, 69B, BS H4B, 825, 925, LECO 501-550, 501-992, 502-106, 502-412, IARM 60A, 67A, 67B, 69B, BS H-4B, LECO 501-644, 501-673, 502-195, 502-412, 502-456, IARM 60B, BS H4.

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

#### See Reverse Side for Statistical Data and Additional Information Regarding this Material.

## The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 05/08/2013.

67C	AI	В	С	Co	Cr	Cu	Fe	Mg	Mn	Mo	N	Nb	Ni	0	Р
1	0.139	0.0020	0.0058	1.718	28.80	1.28	13.44	0.0071	1.012	4.91	0.0331	0.3718	45.62	0.00112	0.007
2	0.124	0.0014	0.0058	1.799	28.906	1.215	13.556	0.0068	1.000	4.934	0.0353	0.358	45.869	0.0019	0.0120
3	0.141	0.0019	0.00585	1.775	28.896	1.202	13.550	0.0067	1.011	4.901	0.0355	0.362	45.360	0.0012	0.009
4	0.1307	0.0001	0.0063	1.7529	28.9180	1.234	13.443	0.0068	1.0256	4.92	0.0346	0.3444	45.935	0.0017	0.0122
5	0.126	0.0014	0.0057	1.73	28.76	1.2078	13.4813	0.0073	0.99	4.922	0.0355	0.356	45.8838	0.0015	0.0094
6	0.1363	0.0004	0.0057	1.729	28.94	1.235	13.52	0.0064	0.997	4.92	0.0358	0.3610	45.82	0.0017	0.012
7	0.156	0.0006	0.0060	1.725	28.879	1.244	13.42	0.0067	1.010	4.951	0.0341	0.3502	45.95	0.0021	0.0122
8	0.1424	0.0010	0.00584	1.7524	29.004	1.277	13.444	0.0067	0.993	4.936	0.0351	0.358	45.57	0.0012	0.0128
9	0.153	0.0011	0.0057	1.745	28.917	1.236	13.5108		1.019	4.9420	0.0351	0.3758	45.969	0.0024	0.008
10	0.1372	0.0008	0.0058	1.7824	28.948	1.282	13.4680		1.013	4.950	0.0340	0.356	45.670	0.0016	0.0120
11	0.130	0.0016			28.989	1.2556	13.449			4.9394	0.0347	0.3667		0.0017	0.0127
12	0.1473	0.0013			28.859	1.234	13.537				0.034			0.0016	0.0125
13						1.229					0.0340				0.013
14															0.0127
Mean	0.1386	0.0011	0.0058	1.7509	28.9013	1.2409	13.4849	0.0068	1.0071	4.9296	0.0347	0.3600	45.7647	0.0016	0.0113
STDV.	0.0101	0.0006	0.0002	0.0271	0.0707	0.0263	0.0478	0.0003	0.0116	0.0162	0.0008	0.0091	0.2013	0.0004	0.0020
Certified	0.14	0.001	0.0058	1.75	28.9	1.24	13.48	0.0068	1.01	4.93	0.035	0.36	45.8	0.0016	0.011
95% C.I.	0.01	0.0004	0.0001	0.02	0.04	0.02	0.03	0.0002	0.01	0.01	0.0005	0.01	0.1	0.0002	0.001
Methods	X,G,I,O	G,I,O	C,O	X,G,I,O	X,G,I,O	X,G,I,O	X,G,I,O	G,A,I,O	X,G,I,O	X,G,I,O	F,O	X,G,I,O	X,I,O	F	X,G,I,O
	Lege	nd: W = Clas	sical, C = Co	mbustion, F	= Fusion, A =	AA or GFAA	, I = ICP or D	CP, D = DC /	Arc, O = AES	, X = XRF, G :	= GDAES or	GDMS, H = H	ollow Cathoo	de AES	
67C	S	Si	Та	Ti	V	w	Ag	As	Bi	Ca	La	Pb	Sb	Sn	Zr
1	0.0005	0.148	0.006	0.0060	0.0309	1.96	< 0.0002	0.00117	< 0.0001	< 0.0001		< 0.0005	0.00023	0.0013	0.0020
2	0.0004	0.119	0.005	0.0039	0.030	2.00	0.000012	0.0020	0.000002	0.0023		0.009	0.00018	0.0012	0.002
3	0.0007	0.129	0.0048	0.0043	0.033	1.941	0.00014	0.0013	0.000001	<0.001		0.000015	0.0004	0.0016	0.001
4	0.0005	0.1569	0.0064	0.004	0.03055	1.9972	0.00004	< 0.00001	0.00002	0.0004		0.00003	0.0003	0.0015	0.0006
5	0.0005	0.1365	0.00575	0.0041	0.032	1.93	0.00005		0.00001	0.00045		0.00003	0.00024	0.00130	0.0011
6	0.0006	0.1448		0.0059	0.0283	1.948	<0.00001		<0.00001			0.00002		0.0015	0.0034
7	0.0007	0.141		0.0059	0.0303	1.95			< 0.00001			< 0.00001		0.0017	0.0023
8	0.00057	0.1418		0.0043	0.0326	1.9800						0.0060			0.0037
9	0.00058	0.137		0.0053	0.031	1.923									0.0010
10	0.0005	0.150		0.0047	0.0311	2.006									
11	0.0005	0.135			0.031	1.991									
12		0.1547				1.984									
Mean	0.0006	0.1411	0.0056	0.0048	0.0310	1.9675	0.0001	0.0015	0.00001	0.0011		0.0025	0.0003	0.0014	0.0019
STDV.	0.0001	0.0108	0.0007	0.0009	0.0013	0.0290	0.0001	0.0004	0.00001	0.0011		0.0040	0.0001	0.0002	0.0011
Certified	0.0006	0.14	(0.006)	0.005	0.031	1.97							(0.0003)	0.0014	0.002
95% C.I.	0.0001	0.01		0.001	0.001	0.02								0.0002	0.001
Methods	G,C,O	X,G,W,I,O	X,O	X,G,I,O	X,G,I,O	X,G,I,O							G,H,I	G,H,I,O	X,G,I,O
Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES															

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

<u>Certifying Body</u>: Any technically competent body (organization or firm, public or private) that issues a reference material certificate, which provides the information, detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards - Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

<u>Certified Reference Material (CRM)</u>: Reference material, accompanied by a certificate, one or more of whose property values are certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

<u>Methods of Analysis:</u> In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing as these processes may contaminate the surface. When not in use, the material should be stored in a cool, dry location. This material was tested using both the solid disks and chips prepared from the disks. The certified values are considered representative of the overall average composition of the material. Chips are not to be used for Oxygen analysis.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length and heat. The majority of materials are in wrought condition; other methods of manufacture are utilized as a less desirable resort. ILAP samples are taken by removing a section, a minimum of, every one-twelfth of total length from the entire bar. A portion of the section is converted to chips and thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis. This systematic sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data. This method of homogeneity testing is in accordance with ISO Guide 34, regarding the systematic selection and testing of a representative number of units for the assessment of homogeneity.

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